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Substitu	ute for form 144	49/PT	0	Complete if known		
				Application Number	10/702,196	
INFO	DRMATION	DISC	CLOSURE	Filing Date	November 4, 2003	
STATEMENT BY APPLICANT				First Named Inventor	Bill Bereza	
•		• ••		Art Unit	2682	
(use	as many shee	ets as	necessary)	Examiner Name	Not yet assigned	
Sheet	1	of	1	Attorney Docket Number	174/267	

		U.S.	PATENT DOCU	MENTS	
Examiner	Cite	Document Number	Publication Date	Name of Patentee or	Pages, Columns, Lines, Where Relevant Passages or Relevant
initials* No.1	Number - Kind Code ² (if known)	MM-DD-YYYY	Applicant of Cited Documents	Figures Appear	
MD		US-2003/0141919 A1	07-31-2003	Wang et al.	
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Examiner Cite		Foreign Patent Document	Publication Date	Name of Patentee or	Pages, Columns, Lines, Where Relevant	_
initials	No.	Country Code 1 - NUMber 2 - Kind Code 1	MM-DD-YYYY	Applicant of Cited Documents	Passages or Relevant Figures Appear	T
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		NON PATENT LITERATURE DOCUMENTS	
Examiner initials	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	τ°
			1

Date Considered	02/23/2007
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through distion if not in conformance and not considered. Include copy of this form with next communication to applicant.

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Applicant is to place a check mark here if English language translation is attached.

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

INFORMATION DISCLOSURE STATEMENT BY APPLICANTS

ATTY. DOCKET 174/267	NO. APPLICATION NO. 10/702,196
APPLICANTS Bill Bereza et al.	CONFIRMATION NO. 7108
FILING DATE November 4, 20	GROUP ART UNIT 2181

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
MD	3,633,120	01/04/72	Battjes	330	30R	
	4,723,110	02/02/88	Voorman	330	252	
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EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
MD	10/317,262		Venkata et al.			12/10/02	
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EXAMINER	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSL	ATION
INITIAL	NUMBER	DATE	COUNTRI	CLASS	30BCEA33	YES	NO
			4				

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FORM PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. 174/267	APPLICATION NO. 10/702,196
	FORMATION DISCLOSURE TATEMENT BY APPLICANTS	APPLICANTS Bill Bereza et al.	CONFIRMATION NO. 7108
,		FILING DATE November 4, 2003	GROUP ART UNIT 2181

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